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(Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		291179US3PCT		New U.S PCT Application Based on PCT/JP04/07725		
				APPLICANT 10580837 - GAU: 2837				
LIST OF	REFEF	RENCES CITED BY AF	PLICANT	Akihide SHIRATSUKI, et al.				
				FILING DATE		GROUP		
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA							
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/E.C./	10		10/0/1007	10		YES	S NO NO	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ				Addi	itional Refe	erences sheet(s) attached	
Examiner /Eduardo Colon Santana/					Date Considered 12/11/2008			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								